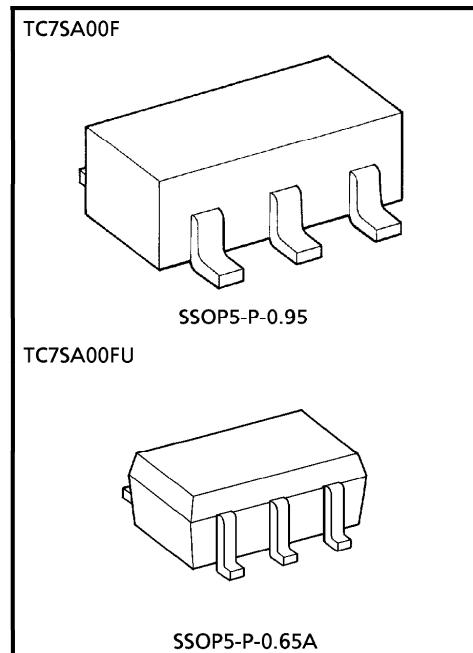


**TC7SA00F, TC7SA00FU****LOW-VOLTAGE 2-INPUT NAND GATE  
WITH 3.6 V TOLERANT INPUTS AND OUTPUTS****FEATURES**

- Low Voltage Operation :  $V_{CC} = 1.8\sim 3.6$  V
- High Speed Operation :  $t_{pd} = 2.8$  ns (max.)  
at  $V_{CC} = 3.0\sim 3.6$  V  
 $t_{pd} = 3.7$  ns (max.)  
at  $V_{CC} = 2.3\sim 2.7$  V  
 $t_{pd} = 7.4$  ns (max.)  
at  $V_{CC} = 1.8$  V
- 3.6 V Tolerant inputs and outputs.
- Output Current :  $I_{OH}/I_{OL} = \pm 24$  mA (min.)  
at  $V_{CC} = 3.0$  V  
 $I_{OH}/I_{OL} = \pm 18$  mA (min.) at  
 $V_{CC} = 2.3$  V  
 $I_{OH}/I_{OL} = \pm 6$  mA (min.) at  
 $V_{CC} = 1.8$  V
- Latch-up Performance :  $\pm 300$  mA
- ESD Performance : Human Body Model  $> \pm 2000$  V  
: Machine Model  $> \pm 200$  V
- Power Down Protection is provided on all inputs and outputs.
- TC74VCX00FT Equivalent



Weight  
SSOP5-P-0.95 : 0.016g (Typ.)  
SSOP5-P-0.65A : 0.006g (Typ.)

# PRELIMINARY

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**MAXIMUM RATINGS**

PARAMETER	SYMBOL	RATING	UNIT
Power Supply Voltage	$V_{CC}$	- 0.5~4.6	V
DC Input Voltage	$V_{IN}$	- 0.5~4.6	V
DC Output Voltage	$V_{OUT}$	- 0.5~4.6 (Note 1)	V
		- 0.5~ $V_{CC}$ + 0.5 (Note 2)	
Input Diode Current	$I_{IK}$	- 50	mA
Output Diode Current	$I_{OK}$	$\pm$ 50 (Note 3)	mA
DC Output Current	$I_{OUT}$	$\pm$ 50	mA
Power Dissipation	$P_D$	200	mW
DC $V_{CC}$ / Ground Current	$I_{CC} / I_{GND}$	$\pm$ 100	mA
Storage Temperature	$T_{stg}$	- 65~150	°C

(Note 1)  $V_{CC} = 0$  V(Note 2) High or Low State.  $I_{OUT}$  absolute maximum rating must be observed.(Note 3)  $V_{OUT} < GND$ ,  $V_{OUT} > V_{CC}$ **PRELIMINARY****RECOMMENDED OPERATING RANGE**

PARAMETER	SYMBOL	RATING	UNIT
Supply Voltage	$V_{CC}$	1.8~3.6	V
		1.2~3.6 (Note 4)	
Input Voltage	$V_{IN}$	- 0.3~3.6	V
Output Voltage	$V_{OUT}$	0~3.6 (Note 5)	V
		0~ $V_{CC}$ (Note 6)	
Output Current	$I_{OH} / I_{OL}$	$\pm$ 24 (Note 7)	mA
		$\pm$ 18 (Note 8)	
		$\pm$ 6 (Note 9)	
Operating Temperature	$T_{opr}$	- 40~85	°C
Input Rise And Fall Time	$dt/dv$	0~10 (Note 10)	ns/V

(Note 4) Data Retention Only

(Note 5)  $V_{CC} = 0$  V

(Note 6) High or Low State

(Note 7)  $V_{CC} = 3.0$ ~3.6 V(Note 8)  $V_{CC} = 2.3$ ~2.7 V(Note 9)  $V_{CC} = 1.8$  V(Note 10)  $V_{IN} = 0.8$ ~2.0 V,  $V_{CC} = 3.0$  V

**ELECTRICAL CHARACTERISTICS**DC characteristics ( $T_a = -40\text{~}85^\circ\text{C}$ ,  $2.7\text{ V} < V_{CC} \leq 3.6\text{ V}$ )

PARAMETER		SYMBOL	TEST CONDITION		$V_{CC}$ (V)	MIN.	MAX.	UNIT	
Input Voltage	"H" Level	$V_{IH}$	$V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OH} = -100\text{ }\mu\text{A}$	2.7~3.6	2.0	—	V	
	"L" Level	$V_{IL}$			2.7~3.6	—	0.8		
Output Voltage	"H" Level	$V_{OH}$		$I_{OH} = -12\text{ mA}$	2.7	2.2	—	V	
				$I_{OH} = -18\text{ mA}$	3.0	2.4	—		
				$I_{OH} = -24\text{ mA}$	3.0	2.2	—		
				$I_{OL} = 100\text{ }\mu\text{A}$	2.7~3.6	—	0.2		
	"L" Level	$V_{OL}$		$I_{OL} = 12\text{ mA}$	2.7	—	0.4	V	
				$I_{OL} = 18\text{ mA}$	3.0	—	0.4		
				$I_{OL} = 24\text{ mA}$	3.0	—	0.55		
Input Leakage Current	$I_{IN}$	$V_{IN} = 0\text{~}3.6\text{ V}$			2.7~3.6	—	$\pm 5.0$	$\mu\text{A}$	
Power Off Leakage Current	$I_{OFF}$	$V_{IN}, V_{OUT} = 0\text{~}3.6\text{ V}$			0	—	10.0	$\mu\text{A}$	
Quiescent Supply Current	$I_{CC}$	$V_{IN} = V_{CC}$ or GND		$V_{CC} \leq (V_{IN}, V_{OUT}) \leq 3.6\text{ V}$	2.7~3.6	—	20.0	$\mu\text{A}$	
					2.7~3.6	—	$\pm 20.0$		
Increase In $I_{CC}$ Per Input	$\Delta I_{CC}$	$V_{IH} = V_{CC} - 0.6\text{ V}$			2.7~3.6	—	750	$\mu\text{A}$	

**PRELIMINARY****ELECTRICAL CHARACTERISTICS**DC characteristics ( $T_a = -40\text{~}85^\circ\text{C}$ ,  $2.3\text{ V} \leq V_{CC} \leq 2.7\text{ V}$ )

PARAMETER		SYMBOL	TEST CONDITION		$V_{CC}$ (V)	MIN.	MAX.	UNIT	
Input Voltage	"H" Level	$V_{IH}$	$V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OH} = -100\text{ }\mu\text{A}$	2.3~2.7	1.6	—	V	
	"L" Level	$V_{IL}$			2.3~2.7	—	0.7		
Output Voltage	"H" Level	$V_{OH}$		$I_{OH} = -6\text{ mA}$	2.3	2.0	—	V	
				$I_{OH} = -12\text{ mA}$	2.3	1.8	—		
				$I_{OH} = -18\text{ mA}$	2.3	1.7	—		
				$I_{OL} = 100\text{ }\mu\text{A}$	2.3~2.7	—	0.2		
	"L" Level	$V_{OL}$		$I_{OL} = 12\text{ mA}$	2.3	—	0.4	V	
				$I_{OL} = 18\text{ mA}$	2.3	—	0.6		
Input Leakage Current	$I_{IN}$	$V_{IN} = 0\text{~}3.6\text{ V}$			2.3~2.7	—	$\pm 5.0$	$\mu\text{A}$	
Power Off Leakage Current	$I_{OFF}$	$V_{IN}, V_{OUT} = 0\text{~}3.6\text{ V}$			0	—	10.0	$\mu\text{A}$	
Quiescent Supply Current	$I_{CC}$	$V_{IN} = V_{CC}$ or GND		$V_{CC} \leq (V_{IN}, V_{OUT}) \leq 3.6\text{ V}_{CC}$	2.3~2.7	—	20.0	$\mu\text{A}$	
					2.3~2.7	—	$\pm 20.0$		

**ELECTRICAL CHARACTERISTICS**DC characteristics ( $T_a = -40\sim85^\circ C$ ,  $1.8 V \leq V_{CC} < 2.3 V$ )

PARAMETER		SYMBOL	TEST CONDITION		$V_{CC}$ (V)	MIN.	MAX.	UNIT	
Input Voltage	"H" Level	$V_{IH}$			1.8~2.3	$0.7 \times V_{CC}$	—	V	
	"L" Level	$V_{IL}$			1.8~2.3	—	$0.2 \times V_{CC}$		
Output Voltage	"H" Level	$V_{OH}$	$V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OH} = -100 \mu A$	1.8	$V_{CC} - 0.2$	—	V	
				$I_{OH} = -6 mA$	1.8	1.4	—		
	"L" Level	$V_{OL}$	$V_{IN} = V_{IH}$	$I_{OL} = 100 \mu A$	1.8	—	0.2		
				$I_{OL} = 6 mA$	1.8	—	0.3		
Input Leakage Current	$I_{IN}$	$V_{IN} = 0\sim3.6 V$			1.8	—	$\pm 5.0$	$\mu A$	
Power Off Leakage Current	$I_{OFF}$	$V_{IN}, V_{OUT} = 0\sim3.6 V$			0	—	10.0	$\mu A$	
Quiescent Supply Current	$I_{CC}$	$V_{IN} = V_{CC}$ or GND			1.8	—	20.0	$\mu A$	
		$V_{CC} \leq (V_{IN}, V_{OUT}) \leq 3.6 V$			1.8	—	$\pm 20.0$		

AC characteristics ( $T_a = -40\sim85^\circ C$ , Input  $t_r = t_f = 2.0$  ns,  $C_L = 30 pF$ ,  $R_L = 500 \Omega$ )

PARAMETER	SYMBOL	TEST CONDITION	$V_{CC}$ (V)	MIN.	MAX.	UNIT
			1.8			
Propagation Delay Time	$t_{pLH}$ $t_{pHL}$	(Fig.1, 2)	1.8	1.5	7.4	ns
			$2.5 \pm 0.2$	1.0	3.7	
			$3.3 \pm 0.3$	0.8	2.8	

For  $C_L = 50 pF$ , add approximately 300 ps to the AC maximum specification.

**PRELIMINARY**

Dynamic switching characteristics ( $T_a = 25^\circ C$ , Input  $t_r = t_f = 2.0$  ns,  $C_L = 30 pF$ )

PARAMETER	SYMBOL	TEST CONDITION	$V_{CC}$ (V)	TYP.	UNIT
			1.8		
Quiet Output Maximum Dynamic $V_{OL}$	$V_{OLP}$	$V_{IH} = 1.8 V, V_{IL} = 0 V$ (Note 11)	1.8	0.25	V
		$V_{IH} = 2.5 V, V_{IL} = 0 V$ (Note 11)	2.5	0.6	
		$V_{IH} = 3.3 V, V_{IL} = 0 V$ (Note 11)	3.3	0.8	
Quiet Output Minimum Dynamic $V_{OL}$	$V_{OLV}$	$V_{IH} = 1.8 V, V_{IL} = 0 V$ (Note 11)	1.8	-0.25	V
		$V_{IH} = 2.5 V, V_{IL} = 0 V$ (Note 11)	2.5	-0.6	
		$V_{IH} = 3.3 V, V_{IL} = 0 V$ (Note 11)	3.3	-0.8	
Quiet Output Minimum Dynamic $V_{OH}$	$V_{OHV}$	$V_{IH} = 1.8 V, V_{IL} = 0 V$ (Note 11)	1.8	1.5	V
		$V_{IH} = 2.5 V, V_{IL} = 0 V$ (Note 11)	2.5	1.9	
		$V_{IH} = 3.3 V, V_{IL} = 0 V$ (Note 11)	3.3	2.2	

(Note 11) Parameter guaranteed by design.

Capacitive characteristics ( $T_a = 25^\circ C$ )

PARAMETER	SYMBOL	TEST CONDITION	$V_{CC}$ (V)	TYP.	UNIT
			1.8, 2.5, 3.3		
Input Capacitance	$C_{IN}$	—	1.8, 2.5, 3.3	6	pF
Power Dissipation Capacitance	$C_{PD}$	$f_{IN} = 10 \text{ MHz}$ (Note 12)	1.8, 2.5, 3.3	20	pF

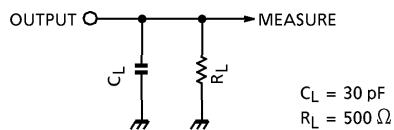
(Note 12)  $C_{PD}$  is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation :

$$I_{CC}(\text{opr.}) = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$$

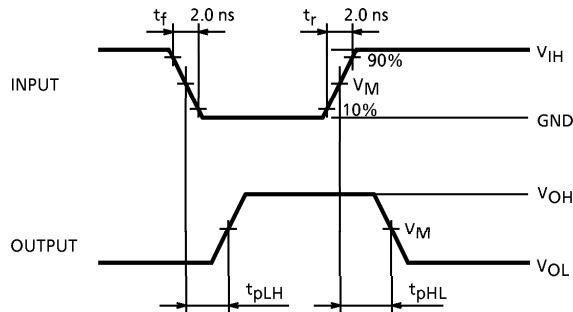
## TEST CIRCUIT

Fig.1



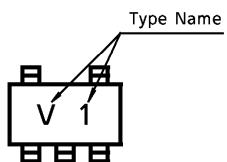
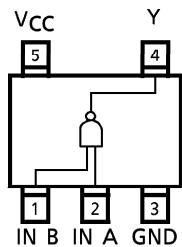
## AC WAVEFORM

Fig.2  $t_{pLH}$ ,  $t_{pHL}$

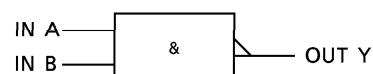


SYMBOL	$V_{CC}$		
	$3.3 \pm 0.3 \text{ V}$	$2.5 \pm 0.2 \text{ V}$	$1.8 \text{ V}$
$V_{IH}$	2.7 V	$V_{CC}$	$V_{CC}$
$V_M$	1.5 V	$V_{CC}/2$	$V_{CC}/2$

# PRELIMINARY

**MARKING****PIN ASSIGNMENT (TOP VIEW)****TRUTH TABLE**

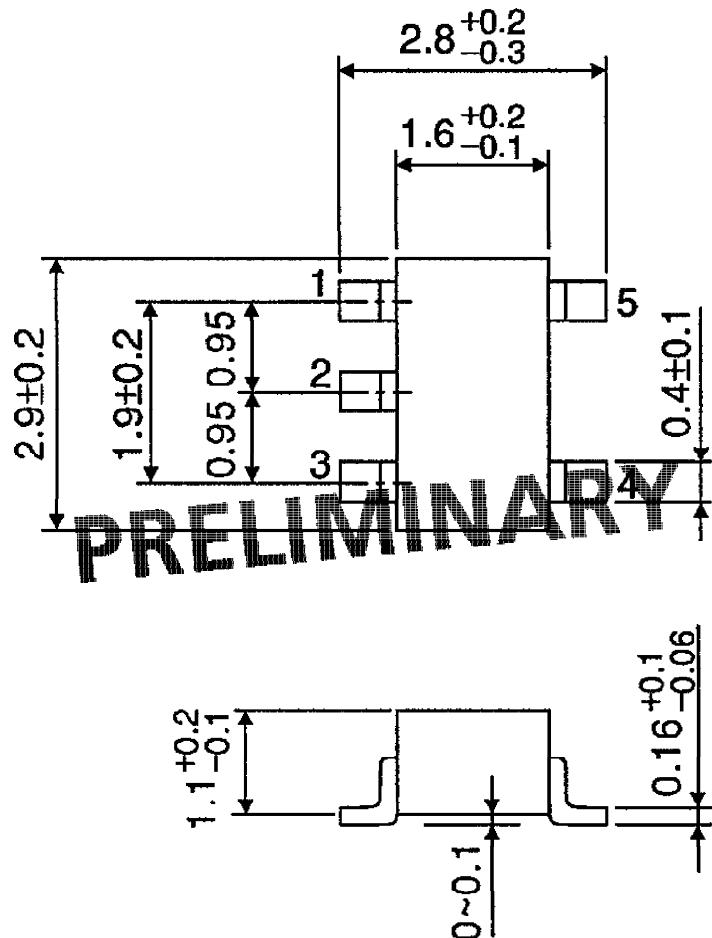
INPUTS		OUTPUTS
A	B	Y
L	L	H
L	H	H
H	L	H
H	H	L

**LOGIC DIAGRAM**

**PRELIMINARY**

**OUTLINE DRAWING**  
SSOP5-P-0.95

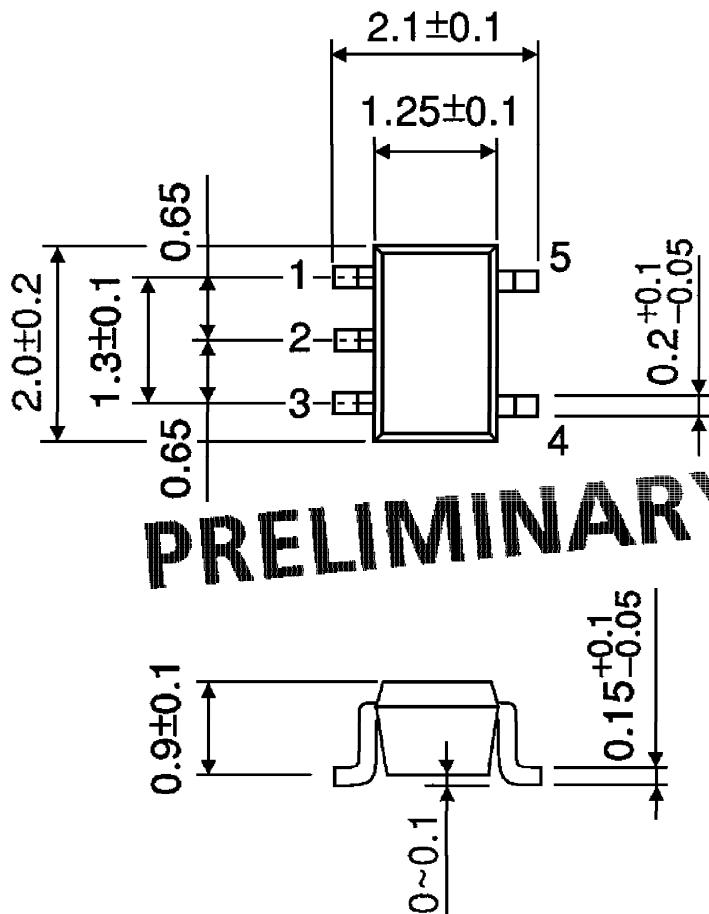
Unit : mm



Weight : 0.016 g (Typ.)

**OUTLINE DRAWING**  
SSOP5-P-0.65A

Unit : mm



Weight : 0.006 g (Typ.)